

<b>Issue Classification</b>			Application/Control No.	Applicant(s)/Patent under Reexamination
			10/086,127	BACH ET AL.
			Examiner Jia W. Lu	Art Unit 2634

**ISSUE CLASSIFICATION**

ORIGINAL		CROSS REFERENCE(S)			
CLASS	SUBCLASS	CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)		
375	346	356	453		
INTERNATIONAL CLASSIFICATION					
H	0	4	D	1/04	
H	0	3	D	1/06	
H	0	3	K	5/01	
H	0	4	B	1/10	
H	0	4	L	1/00	
Jia Lu 9/16/05 (Assistant Examiner) (Date)				 STEPHEN CHIN 9/17/05 SUPERVISORY PATENT EXAMINEE TECHNOLOGY CENTER 2600 (Primary Examiner) (Date)	Total Claims Allowed: 27
 Lashawn Marks 9/20/05 (Legal Instruments Examiner) (Date)				O.G. Print Claim(s) 1	O.G. Print Fig. 1

<input checked="" type="checkbox"/> Claims renumbered in the same order as presented by applicant		<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R. 1.47	
Final	Original	Final	Original	Final	Original	Final	Original
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5	35	65	95	125	155	155	185
6	36	66	96	126	156	156	186
7	37	67	97	127	157	157	187
8	38	68	98	128	158	158	188
9	39	69	99	129	159	159	189
10	40	70	100	130	160	160	190
11	41	71	101	131	161	161	191
12	42	72	102	132	162	162	192
13	43	73	103	133	163	163	193
14	44	74	104	134	164	164	194
15	45	75	105	135	165	165	195
16	46	76	106	136	166	166	196
17	47	77	107	137	167	167	197
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19	49	79	109	139	169	169	199
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21	51	81	111	141	171	171	201
22	52	82	112	142	172	172	202
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24	54	84	114	144	174	174	204
25	55	85	115	145	175	175	205
26	56	86	116	146	176	176	206
27	57	87	117	147	177	177	207
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